SPECIFICATION

VXT280GQSW-01

- ☐ Preliminary Specification
- ☐ Final Specification



Approved By:		
Date:		

RECORD OF REVISION

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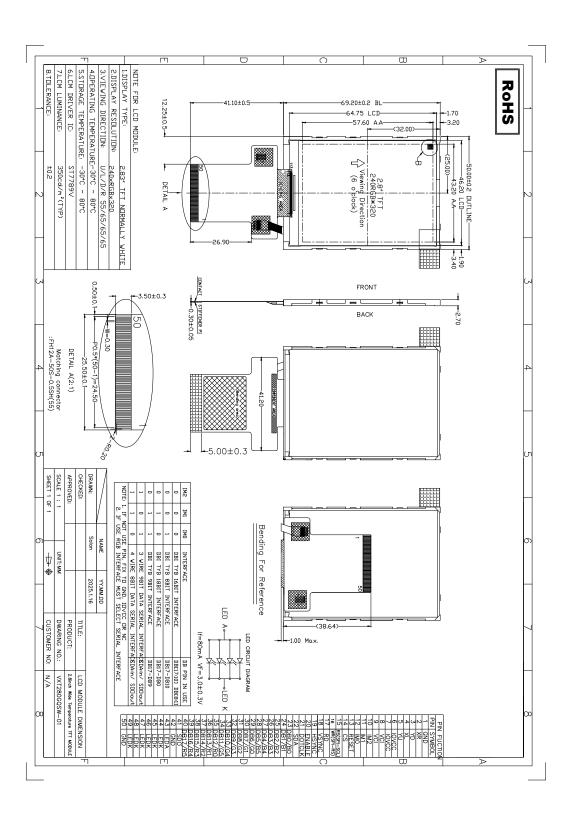
1. Scope

VXT280GQSW-01 is a TFT-LCD module. It is composed of a TFT-LCD panel, driver IC, FPC,a back light unit. The 2.8" display area contains 240x320 pixels and can display up to 262K colors. This product accords with RoHS environmental criterion.

2. General Specifications

Item	Contents	Unit	Note
LCD Type	TFT	-	
Display color	262K		
Viewing Direction	6	O'Clock	
Gray scale inversion direction	12	O'Clock	
Operating temperature	-30~+80	°C	
Storage temperature	-30~+80	°C	
Module size	2.8	inch	
Active Area(W×H)	43.20x57.60	mm	
Number of Dots	240*320	dots	
Controller	ST7789V	-	
Power Supply Voltage	3.3	V	
Outline Dimensions	50.00x69.20x2.7	mm	
Backlight	4X1-LEDs (white)	pcs	
Weight		g	
Interface	RGB/MCU/SPI	-	

3. Outline Drawing



4. Interface Description

Pin No	Symbol	1/0	Function								
1	GND	Р	Ground .	Ground .							
2	XR	I									
3	YD	I	TD Din if n	TD Din if not use Diagon NC							
4	XL	I	TP PIN,IT N	TP Pin,if not use ,Please NC.							
5	YU	1]								
6-7	IOVCC	Р	Power Sup	ply for IO							
8-9	VCI	Р	Power Sup	oply for logic.							
			IM2	IM1	IM0	Interface Mode	DB PIN in use				
10	IM2	I	0	0	0	80 MCU 16-bit bus	D[17:10], D[8:1]				
44	15.44		0	0	1	80 MCU 8-bit bus	D[17:10]				
11	IM1	I	0	1	0	80 MCU 18-bit bus	D[17:0]				
			0	1	1	80 MCU 9-bit bus	D[17:9]				
12	IM0	I	1	0	1	3-wire 9-bit data serial	SDI: In ,SDO: Out				
			1	1	0	4-wire 8-bit data serial	SDI: In ,SDO: Out				
13	RESET	1	Reset sign	al,Signal is ac	tive low.						
14	CS	I	Chip selec	t input pin.							
15	RS(SPI-SCL)	ı	Display da	ta/command	selection p	in in parallel interface.					
15	NO(SF1-SCL)	'	This pin is	used to be se	erial interfac	ce clock.					
16	WR(SPI-RS)	I		ble in MCU pata/command		face in in serial interface.					
17	RD	I	Read enab	ole in MCU pa	rallel interf	ace.					
18	VSYNC	I	Vertical (F	rame) synchr	onizing inpu	ut signal for RGB interface o	peration.				
19	HSYNC	_	Horizonta	(Line) synch	ronizing inp	ut signal for RGB interface o	pperation.				
20	ENABLE	I	Data enab	le signal for F	RGB interfac	ce operation.					
21	DOTCLK	1	Dot clock	signal for RGI	3 interface o	operation.					
22	SDA	1	SPI interfa	ce data input	/output pi	n.					
23-40	DB0-DB17	1	Data input.								
41	SDO	0	SPI interfa	ce data outp	ut pin.						
42	GND	Р	Ground.								
43	LEDA	Р	LED anode.								
44-49	LEDK	Р	LED cathode.								
50	GND	Р	Ground.								

5. Absolute Maximum Ratings(Ta=25°C)

5.1 Electrical Absolute Maximum Ratings.(Vss=0V,Ta=25°C)

Item	Symbol	Min.	Max.	Unit	Note
Power Supply Voltage	VCI	-0.3	4.6	V	
Power Supply Voltage(Logic)	IOVCC	-0.3	4.6	V	1, 2

Notes:

- 1. If the module is above these absolute maximum ratings. It may become permanently damaged. Using the module within the following electrical characteristic conditions are also exceeded, the module will malfunction and cause poor reliability.
- 2. $V_{DD} > V_{SS}$ must be maintained.

5.2 Environmental Absolute Maximum Ratings.

	Storage		Operat	ing	
Item	MIN.	MAX.	MIN.	MAX.	Note
Ambient Temperature	-30°C	80°C	-30℃	80°C	1,2
Humidity	-	-	-	-	3

- 1. The response time will become lower when operated at low temperature.
- ${\bf 2.}\ {\bf Background\ color\ changes\ slightly\ depending\ on\ ambient\ temperature.}$

The phenomenon is reversible.

3. Ta<= 40° C:85%RH MAX.

Ta>= 40° C:Absolute humidity must be lower than the humidity of 85%RH at 40° C.

6. Electrical Specifications and Instruction Code

6.1 Electrical characteristics(Vss=0V ,Ta=25°C)

Parameter		Symbol	Condition	Min	Тур	Max	Unit	Note
		VCI	To - 25°C	2.4	2.75	3.3	V	
Power su	рріу	IOVCC	Ta=25°C	1.65	1.8	3.3	V	
Input	'H'	V _{IH}	V _{CC} =3.3V	0.7V _{DDI}	-	V _{DDI}	V	
voltage	'Ľ	V _{IL}	V _{CC} =3.3V	0	-	0.3V _{DDI}	V	
Current Consumption		Icc	Ta=25°C	1	TBD	-	mA	
		l _{iovcc}	1d-25 C	-	TBD	-	mA	

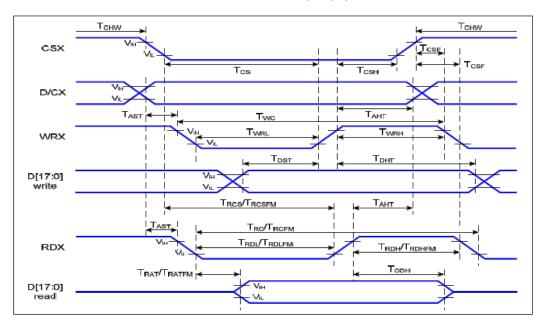
Note:

1:When an optimum contrast is obtained in transmissive mode.

2: Tested in 1×1 chessboard pattern.

7. Timing Characteristics

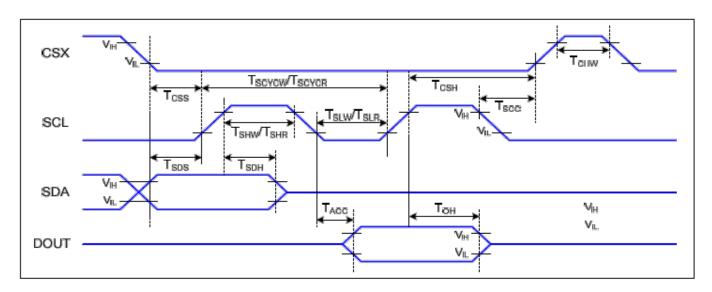
7.1 8080 Series MCU Parallel Interface Characteristics: 18/16/9/8-bit Bus



VDDI=1.65 to 3.3V, VDD=2.4 to 3.3V, AGND=DGND=0V, Ta=25 $^{\circ}\text{C}$

Signal	Symbol	Parameter	Min	Max	Unit	Description
D/CX	TAST	Address setup time	0		ns	
DIASA	TAHT	Address hold time (Write/Read)	10		ns	-
	T _{CHW}	Chip select "H" pulse width	0		ns	
	Tes	Chip select setup time (Write)	15		ns	
CSX	TRES	Chip select setup time (Read ID)	45		ns	
COA.	TROSEM	Chip select setup time (Read FM)	355		ns	_
	Tesp	Chip select wait time (Write/Read)	10		ns	
	Tosh	Chip select hold time	10		ns	
	Twe	Write cycle	66		ns	
WRX	T _{WRH}	Control pulse "H" duration	15		ns	
	T _{WRL}	Control pulse "L" duration	15		ns	
	T_{RG}	Read cycle (ID)	160		ns	
RDX.(ID)	TROH	Control pulse "H" duration (ID)	99		ns	When read ID data
	T _{RDL}	Control pulse "L" duration (ID)	45		ns	
RDX	TROFM	Read cycle (FM)	450		ns	When read from
(FM)	TROHFM	Control pulse "H" duration (FM)	90		ns	frame memory
gi miy	T _{RDLFM}	Control pulse "L" duration (FM)	355		ns	manie memory
	T_{DST}	Data setup time	10		ns	For CL=30pF
	T _{DHT}	Data hold time	10		ns	
D[17:0]	T _{BAT}	Read access time (ID)		40	ns	
	TRATEM	Read access time (FM)		340	ns	
	Тоон	Output disable time	20	80	ns	

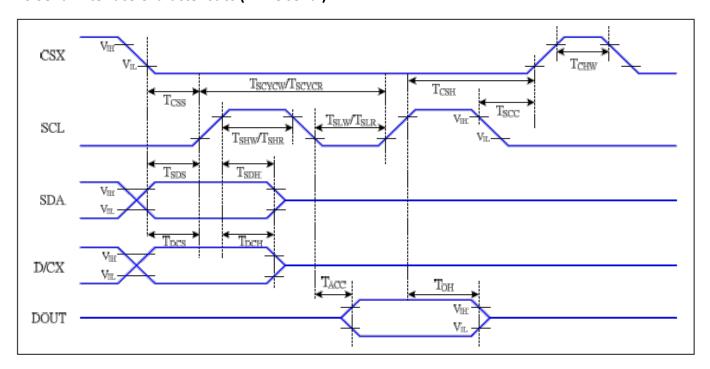
7.2 Serial Interface Characteristics (3-line serial):



VDDI=1.65 to 3.3V, VDD=2.4 to 3.3V, AGND=DGND=0V, Ta=25°C

Signal	Symbol	Parameter	Min	Max	Unit	Description
	T _{CSS}	Chip select setup time (write)	15		ns	
	T _{CSH}	Chip select hold time (write)	15		ns	
CSX	T _{CSS}	Chip select setup time (read)	60		ns	
	Tscc	Chip select hold time (read)	65		ns	
	T _{©HW}	Chip select "H" pulse width	40		ns	
	T _{scycw}	Serial clock cycle (Write)	66		ns	
	T _{SHW}	SCL "H" pulse width (Write)	15		ns	
SCL	T _{SLW}	SCL "L" pulse width (Write)	15		ns	
SCL	T _{SCYCR}	Serial clock cycle (Read)	150		ns	
	T _{SHR}	SCL "H" pulse width (Read)	60		ns	
	T _{SLR}	SCL "L" pulse width (Read)	60		ns	
SDA	T _{SDS}	Data setup time	10		ns	
(DIN)	T _{SDH}	Data hold time	10		ns	
DOUT	TACC	Access time	10	50	ns	For maximum CL=30pF
DOUT	Тон	Output disable time	15	50	ns	For minimum CL=8pF

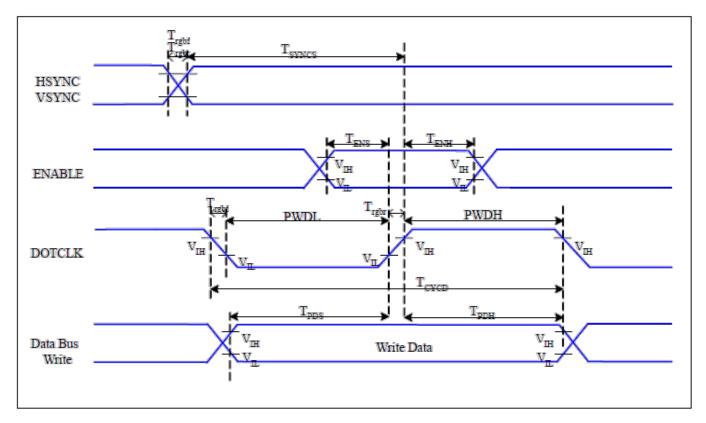
7.3 Serial Interface Characteristics (4-line serial):



VDDI=1.65 to 3.3V, VDD=2.4 to 3.3V, AGND=DGND=0V, Ta=25 $^{\circ}\text{C}$

Signal	Symbol	Parameter	MIN	MAX	Unit	Description
	T _{CSS}	Chip select setup time (write)	15		ns	
	T _{CSH}	Chip select hold time (write)	15		ns	
CSX	Tess	Chip select setup time (read)	60		ns	
	T _{scc}	Chip select hold time (read)	65		ns	
	T _{CHW}	Chip select "H" pulse width	40		ns	
	T _{SCYCW}	Serial clock cycle (Write)	66		ns	
	T _{SHW}	SCL "H" pulse width (Write)	15		ns	-write command & data
SCL	T _{SLW}	SCL "L" pulse width (Write)	15		ns	ram
SCL	T _{SCYCR}	Serial clock cycle (Read)	150		ns	
	T _{SHR}	SCL "H" pulse width (Read)	60		ns	-read command & data
	T _{SLR}	SCL "L" pulse width (Read)	60		ns	ram
D/CX	Tpcs	D/CX setup time	10		ns	
DIGA	TDCH	D/CX hold time	10		ns	
SDA	T _{SDS}	Data setup time	10		ns	
(DIN)	T _{SDH}	Data hold time	10		ns	
DOUT	T _{ACC}	Access time	10	50	ns	For maximum CL=30pF
DOUT	Тон	Output disable time	15	50	ns	For minimum CL=8pF

7.4 RGB Interface Characteristics:

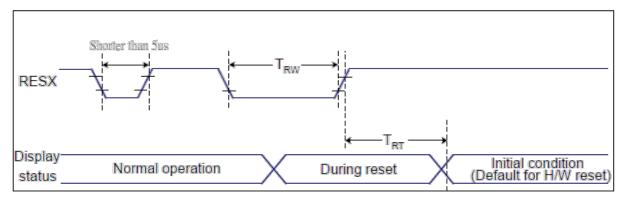


18/16 Bits RGB Interface Timing Characteristics

Signal	Symbol	Parameter	MIN	MAX	Unit	Description
HSYNC, VSYNC	T _{SYNCS}	VSYNC, HSYNC Setup Time	30	-	ns	
ENABLE	T _{ENS}	Enable Setup Time	25	-	ns	
LINABLL	T _{ENH}	Enable Hold Time	25	-	ns	
	PWDH	DOTCLK High-level Pulse Width	60	-	ns	
DOTCLK	PWDL	DOTCLK Low-level Pulse Width	60	-	ns	
DOTCER	Teyed	DOTCLK Cycle Time	120	-	ns	
	Trghr, Trghf	DOTCLK Rise/Fall time	-	20	ns	
DD.	T _{PDS}	PD Data Setup Time	50	-	ns	
DB	T _{PDH}	PD Data Hold Time	50	-	ns	

Signal	Symbol	Parameter	MIN	MAX	Unit	Description
HSYNC,	T	VCVNC LICVNC Cotus Times	25			
VSYNC	T _{SYNCS}	VSYNC, HSYNC Setup Time	25	-	ns	
ENABLE	T _{ENS}	Enable Setup Time	25	-	ns	
	T _{ENH}	Enable Hold Time	25	-	ns	
	PWDH	DOTCLK High-level Pulse Width	25	-	ns	
DOTCLK	PWDL	DOTCLK Low-level Pulse Width	25	-	ns	
DOTCLK	T _{CYCD}	DOTCLK Cycle Time	55	-	ns	
	Trghr, Trghf	DOTCLK Rise/Fall time	-	10	ns	
DB	T _{PDS}	PD Data Setup Time	25	-	ns	
DB	T _{PDH}	PD Data Hold Time	25	-	ns	

7.5 Reset Timing:



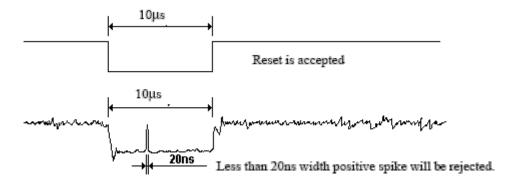
Related Pins Symbol		Parameter	MIN	MAX	Unit
	TRW	Reset pulse duration	10	-	us
RESX	TRT Reset cancel	Donat cancel	-	5 (Note 1, 5)	ms
			120 (Note 1, 6, 7)	ms	

Notes:

- 1. The reset cancel includes also required time for loading ID bytes, VCOM setting and other settings from NVM (or similar device) to registers. This loading is done every time when there is HW reset cancel time (tRT) within 5 ms after a rising edge of RESX.
- 2. Spike due to an electrostatic discharge on RESX line does not cause irregular system reset according to the table below:

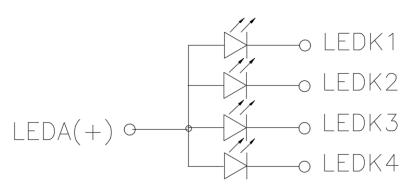
RESX Pulse	Action
Shorter than 5us	Reset Rejected
Longer than 9us	Reset
Between 5us and 9us	Reset starts

- 3. During the Resetting period, the display will be blanked (The display is entering blanking sequence, which maximum time is 120 ms, when Reset Starts in Sleep Out –mode. The display remains the blank state in Sleep In –mode.) and then return to Default condition for Hardware Reset.
- 4. Spike Rejection also applies during a valid reset pulse as shown



- 5. When Reset applied during Sleep In Mode.
- 6. When Reset applied during Sleep Out Mode.
- 7. It is necessary to wait 5msec after releasing RESX before sending commands. Also Sleep Out command cannot be sent for 120msec.

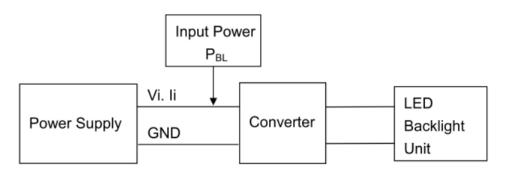
8.Backlight Characteristic



Item	Symbol	Min	Тур	Max	Unit	Test Condition
Supply Voltage	Vf	2.8	3.0	3.3	V	Note 1
Supply Current	If	-	80	-	mA	Note 2
Life Time	-	30000	-	-	Hr	Note 3,4
Backlight Color			W	hite		

Note 1: The LED Supply Voltage is defined by the number of LED at Ta=25°C and If =80mA.

Note 2: LED current is measured by utilizing a high frequency current meter as shown below:



Note 3: The "LED life time" is defined as the module brightness decrease to 50% original brightness at $Ta=25^{\circ}C$ and If =80mA. The LED lifetime could be decreased if operating If is larger than 80mA.

9. Optical Characteristics

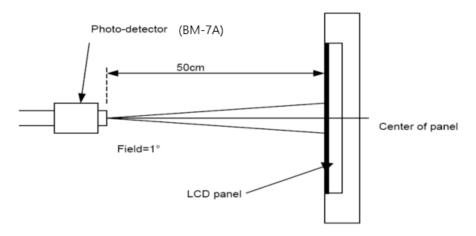
Item	Syn	nbol	Condition	Min.	Тур.	Max.	Unit	Note
Brightness	В	р	If=80mA		350	-	Cd/m ²	1
Uniformity	⊿	Вр	If=80mA	80	-	-	%	1,2
	3:	00		-	65	-		
	6:	00		-	65	-	_	
Viewing Angle	9:00		Cr≥10	-	65	-	Deg	1,2
	12:00			-	55	-		
Contrast Ratio	(Cr		-	500	-	-	3,4
Response Time	$T_{r+}T_{f}$		θ=0°	-	30	35	ms	4,5
	W				TBD		-	
Color of CIE Coordinate	VV	У	θ=0°	TYP	TBD	TYP	-	1,6
	В	Х	Ф=0°	-0.05	TBD	+0.05	-	
	R	У			TBD		-	

	G	х (•		TBD		-	
)	У			TBD		-	
	В	Х			TBD		-	
	D	У			TBD		-	
NTSC Ratio	(5		-	50	-	%	

^{*}The parameter is slightly changed by temperature, driving voltage and materiel

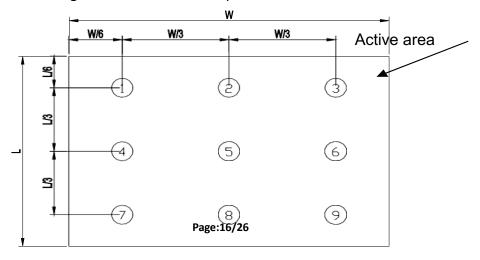
Note 1: The data are measured after LEDs are turned on for 5 minutes. LCM displays full white. The brightness is the average value of 9 measured spots. Measurement equipment BM-7A (Φ8mm)Measuring condition:-Measuring surroundings: Dark room.-Measuring temperature: Ta=25℃.-Adjust operating voltage to get optimum contrast at the center of the display.

The measured value is more than 5 minutes at the center point of the LCD panel, and the backlight is turned on at the same time.

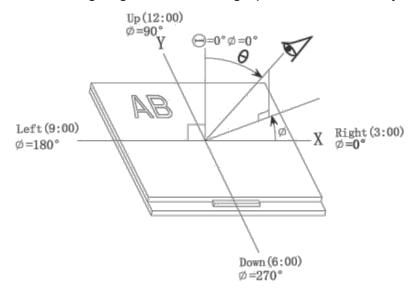


Note 2: The luminance uniformity is calculated by using following formula.

△Bp = Bp (Min.) / Bp (Max.)×100 (%);Bp (Max.) = Maximum brightness in 9 measured spots Bp (Min.) = Minimum brightness in 9 measured spots.

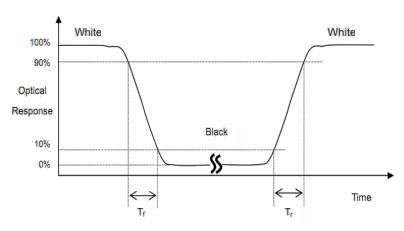


Note 3: The definition of viewing angle:Refer to the graph below marked by θ and Φ

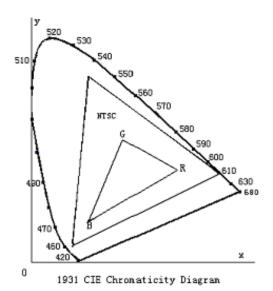


Note 4: Definition of contrast ratio Contrast measurements shall be made at viewing angle of Θ = 0 and at the center of the LCD surface. Luminance shall be measured with all pixels in the view field set first to white, then to the dark (black) state.

Note 5: Definition of Response time The output signals of photo detector are measured when the input signals are changed from "white" to "black"(Tf) and from "black" to "white"(Tr), respectively. The response time is defined as the time interval between the 10% and 90% of amplitudes. Refer to figure as below.



Note 6: Definition of Color of CIE Coordinate and NTSC Ratio.



Color gamut:

$$S = \frac{area~of~RGB~triangle}{area~of~NTSC~triangle} \times 100\%$$

10. Reliability Test Conditions and Methods

No.	Test Items	Test Condition	Inspection After Test
1	High Temperature Storage	80°C±2°C×240Hours	Inspection after 2~4hours storage at room temperature, the
2	Low Temperature Storage	-30°C±2°C×240Hours	samples should be free from
3	High Temperature Operating	80°C±2°C×240Hours	defects: 1, Air bubble in the LCD.
4	Low Temperature Operating	-30°C±2°C×240Hours	2, Seal leak.
(5)	Temperature Cycle(Storage)	-30°C	 3, Non-display. 4, Missing segments. 5, Glass crack. 6, Current IDD is twice higher than initial value.
6	Damp Proof Test (Storage)	60°C±5°C×90%RH×240Hours	7, The surface shall be free from damage. 8, The electric characteristic requirements shall be satisfied. 9.Brightness reduction more than 50%.

REMARK:

- 1, The Test samples should be applied to only one test item.
- 2, Sample side for each test item is 5~10pcs.
- 3,For Damp Proof Test, Pure water(Resistance > 10M Ω)should be used.
- 4,In case of malfunction defect caused by ESD damage, if it would be recovered to normal state after resetting, it would be judge as a good part.
- 5, EL evaluation should be accepted from reliability test with humidity and temperature: Some defects such as black spot/blemish can happen by natural chemical reaction with humidity and Fluorescence EL has.
- 6, Failure Judgment Criterion: Basic Specification Electrical Characteristic, Mechanical Characteristic, Optical Characteristic.

11. Inspection Standard

11.1 Scope

Specifications contain

11.1.1 Display Quality Evaluation

11.1.2 Mechanics Specification

11.2 Sampling Plan

Unless there is other agreement, the sampling plan for incoming inspection shall follow MIL-STD-105E.

11.2.1 Lot size: Quantity per shipment as one lot (different model as different lot).

11.2.2 Sampling type: Normal inspection, single sampling.

11.2.3 Sampling level: Level II.

11.2.4 AQL: Acceptable Quality Level

Major defect: AQL=0.65 Minor defect: AQL=1.5

11.3 Panel Inspection Condition

11.3.1 Environment:

Room Temperature: 25±5°C.

Humidity: 65±5% RH.

Illumination: 300 ~ 700 Lux.

11.3.2 Inspection Distance:

35±5 cm

11.3.3 Inspection Angle:

The vision of inspector should be perpendicular to the surface of the Module.

11.3.4 Inspection time:

Perceptibility Test Time: 20 seconds max.

11.4 Inspection Plan

Class	Item	Judgment	Class
	Outside and inside package.	"MODEL NO.", "LOT NO." and "QUANTITY" should indicate on the package.	Minor
Packing & Indicate	2. Model mixed and quantity.	Other model mixed Quantity short or over	Major
	3. Product indication.	"MODEL NO." should indicate on the product.	Major
Assembly	4. Dimension, LCD glass scratch and scribe defect.	According to specification or drawing.	Major
	5. Viewing area.	Polarizer edge or LCD's sealing line is visible in the viewing areaRejected.	Minor
	6. Blemish, black spot, white spot in the LCD and LCD glass cracks.	According to standard of visual inspection.(inside viewing area)	Minor
Appearance	7. Blemish, black spot, white spot and scratch on the polarizer.	According to standard of visual inspection.(inside viewing area)	Minor
	8. Bubble in polarizer.	According to standard of visual inspection.(inside viewing area)	Minor
	9. LCD's rainbow color.	Strong deviation color (or newton ring) of LCDRejected. Or according to limited sample.(if needed, and inside viewing area)	Minor
	10. Electrical and optical characteristics.(contrast Vop chromaticityetc)	According to specification or drawing.(inside viewing area)	Major
	11. Missing line.	Missing dot line character	Major
Electrical	12.Short circuit. Wrong pattern display.	No display, wrong pattern display, current consumption. Out of specification	Major
	13. Dot defect.(for color and TFT)	According to standard of visual Inspection.	Minor

11.5 Standard Of Visual Inspection

NO.	CLASS	ITEM	JUDGMENT			
			(A) Round type:	Unit: mm		
			Diameter (mm.)	Acceptable Q'ty		
			Φ≦0.1	Disregard		
			0.1 < Φ≦0.25	2(Distance>10mm)		
		Black and white spot.	0.25 < Ф	0		
		Foreign materiel.	Note: Φ = (length+widt	th)/2		
11.5.1	Minor	Dust.	(B) Linear type:	Unit: mm		
		Blemish.	Length Width (mm	.) Acceptable Q'ty		
		Scratch.	W≦0.03	Disregard		
			L≦3.0 0.03< W≦0.0			
			0.05 < W	Not allow		
				_		
				Unit: mm.		
			Diameter	Acceptable Q'ty		
11.5.2	11.5.2 Minor	Dent on polarizer.	Φ≦0.1	Disregard		
			0.1 < Φ≦0.25	2(Distance>10mm)		
			0.25 < Ф	0		
				Unit: mm.		
		Bubble in polarizer.	Diameter	Acceptable Q'ty		
11.5.3	Minor		Ф≦0.1	Disregard		
			0.1< Φ≦0.25	2(Distance>10mm)		
			0.25 < Ф	0		
			Items	Acceptable Q'ty		
			Bright dot	N ≦3		
			Dark dot	N ≦3		
			Total dot	N ≦6		
11.5.4	Minor	Dot defect	whole dot is regarded a Note 2: Bright dot: Dots appea which LCD panel is displ Note 3: The bright dot defect mu Note 4: Dark dot: Dots appear d	bt Dot e size of a defective dot over 1/2 of as one defective dot. or bright and unchanged in size in laying under black pattern.		

11.5.5	Minor	LCD glass chipping.	Y S	Y>S Reject
11.5.6	Minor	LCD glass chipping.	SY	X or Y>S Reject
11.5.7	Major	LCD glass crack.	Y	Y>(1/2) T Reject
11.5.8	Major	LCD glass scribe defect.	$A^{\frac{1}{7}}_{\uparrow \leftarrow a \rightarrow \uparrow} \xrightarrow{\downarrow } B$	1. a>L/3, A>1.5mm Reject 2. B : According to dimension
11.5.9	Minor	LCD glass chipping. (on the terminal area)	T	Φ = (x+y)/2>2.5mm Reject
11.5.10	Minor	LCD glass chipping. (on the terminal surface)	T Z X	Y>(1/3)T Reject
11.5.11	Minor	LCD glass chipping.	T Z	Y>T Reject

12. Handling Precautions

12.1 Mounting method

The TFT module consists of two thin glass plates with polarizes which easily be damaged. And since the module in so constructed as to be fixed by utilizing fitting holes in the printed circuit board.

Extreme care should be needed when handling the LCD modules.

12.2 Caution of LCD handling and cleaning

When cleaning the display surface, Use soft cloth with solvent

[Recommended below] and wipe lightly.

- Isopropyl alcohol.
- Ethyl alcohol.

Do not wipe the display surface with dry or hard materials that will damage the polarizer surface. Do not use the following solvent:

- Water.
- Aromatics.

Do not wipe ITO pad area with the dry or hard materials that will damage the ITO patterns Do not use the following solvent on the pad or prevent it from being contaminated:

- Soldering flux.
- Chlorine (CI), Sulfur (S).

If goods were sent without being silicon coated on the pad, ITO patterns could be damaged due to the corrosion as time goes on.

If ITO corrosion happen by miss-handling or using some materials such as Chlorine (CI), Sulfur (S) from customer, Responsibility is on customer.

12.3 Caution against static charge

The LCD module use C-MOS LSI drivers, so we recommended that you:

Connect any unused input terminal to POWER or GROUND, do not input any signals before power is turned on, and ground your body, work/assembly areas, and assembly equipment to protect against static electricity.

12.4 packing

- Module employs LCD elements and must be treated as such.
- Avoid intense shock and falls from a height.
- To prevent modules from degradation, do not operate or store them exposed direct to sunshine or high temperature/humidity.

12.5 Caution for operation

- It is an indispensable condition to drive LCD's within the specified voltage limit since the higher voltage then the limit cause the shorter LCD life.
- An electro chemical reaction due to direct current causes LCD's undesirable deterioration, so that the use of direct current drive should be avoided.
- Response time will be extremely delayed at lower temperature then the operating temperature range and on the other hand at higher temperature LCD's how dark color in them. However those phenomena do not mean malfunction or out of order with LCD's, which will come back in the specified operation temperature.
- If the display area is pushed hard during operation, some font will be abnormally displayed but it resumes normal condition after turning off once.
- Slight dew depositing on terminals is a cause for electro-chemical reaction resulting in terminal open circuit.

Usage under the maximum operating temperature, 50%Rh or less is required.

12.6 storing

In the case of storing for a long period of time for instance, for years for the purpose or replacement use, the following ways are recommended.

- Storage in a polyethylene bag with the opening sealed so as not to enter fresh air outside in it. And with no desiccant.
- Placing in a dark place where neither exposure to direct sunlight nor light's keeping the storage temperature range.
- Storing with no touch on polarizer surface by the anything else.
 [It is recommended to store them as they have been contained in the inner container at the time of delivery from us.

12.7 Safety

- It is recommendable to crash damaged or unnecessary LCD's into pieces and wash off liquid crystal by either of solvents such as acetone and ethanol, which should be burned up later.
- When any liquid leaked out of a damaged glass cell comes in contact with your hands, please wash
 it off well with soap and water.

13. Precaution for Use

13.1

A limit sample should be provided by the both parties on an occasion when the both parties agreed its necessity. Judgment by a limit sample shall take effect after the limit sample has been established and confirmed by the both parties.

13.2

On the following occasions, the handing of problem should be decided through discussion and agreement between responsible of the both parties.

- When a question is arisen in this specification
- When a new problem is arisen which is not specified in this specifications
- When an inspection specifications change or operating condition change in customer is reported to TFT, and some problem is arisen in this specification due to the change
- When a new problem is arisen at the customer's operating set for sample evaluation in the customer site.

- END